



IFW

# TRANSMITTAL OF FORMAL DRAWINGS

Docket No.  
BUR920020113US1

In Re Application Of: Conti et al.

Application No.	Filing Date	Examiner	Customer No.	Group Art Unit	Confirmation No.
10/604,230	07/02/03	M. Tang	29154	2829	1229

Invention: APPLYING PARAMETRIC TEST PATTERNS FOR HIGH PIN COUNT ASICS ON LOW PIN COUNT TESTERS

Address to:  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Transmitted herewith are:

9 sheets of formal drawing(s) for this application.

☒ Each sheet of drawing indicates the identifying indicia suggested in 37 CFR Section 1.84(c).

Signature

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Dated: September 30, 2004

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to "Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450" [37 CFR . 3(a)] on 9/30/04

(Date)  
  
Signature of Person Mailing Correspondence

Frederick W. Gibb, III

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